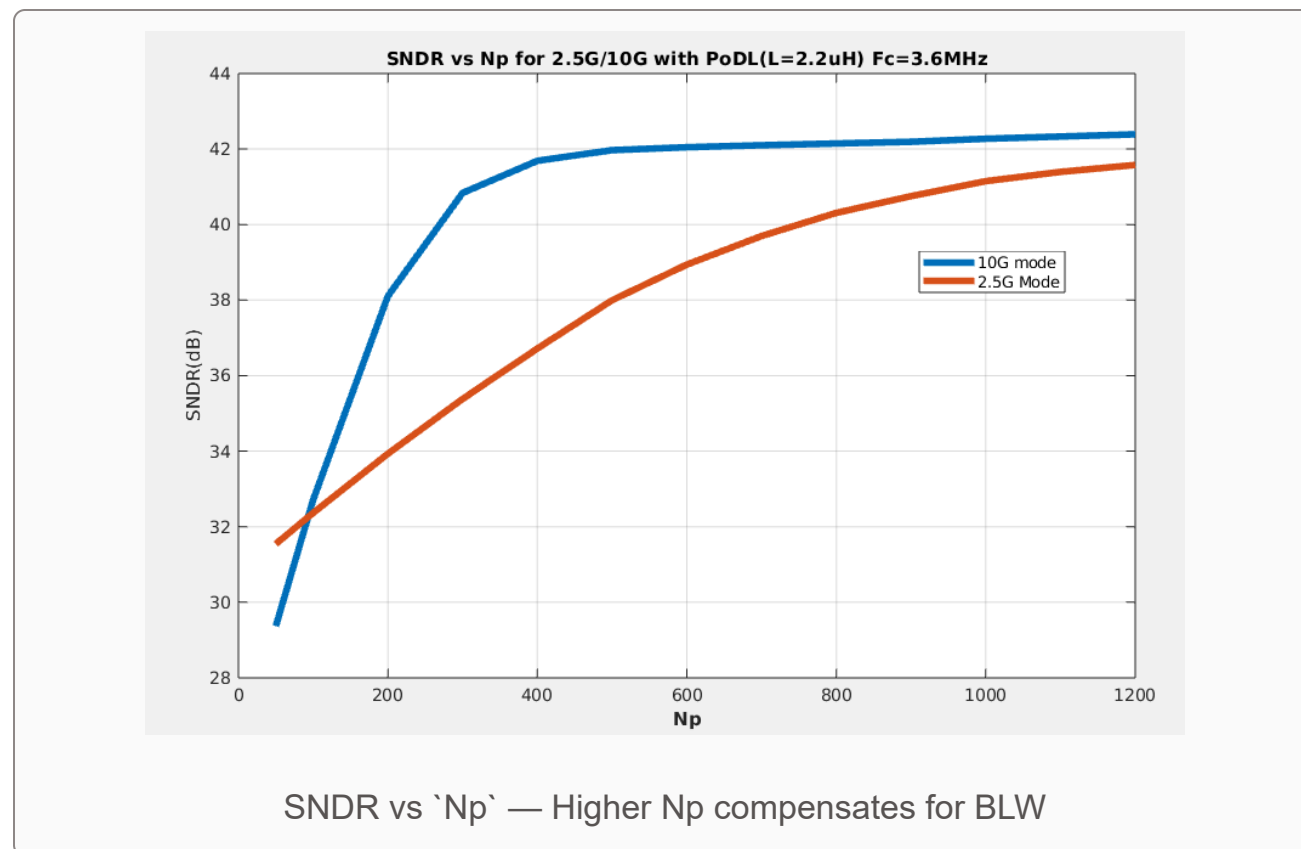


# Impact of High Pass Filtering on ACT Testmode 4 SNDR measurements

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# How TM4 SNDR is measured (802.3ch / 802.3dm)

1. DUT PHY transmits a known **PRBS13Q** pattern
2. Scope captures the **MDI waveform** and computes a **linear-fit pulse response**; peak  $P_{max}$  = linear, distortion-free signal within an  $N_p$  -long window
3. **Nonlinearity power**  $\sigma_e^2$  = residual between captured MDI and linear-fit reconstruction
4. **Random-noise power**  $\sigma_n^2$  = variance across repeated captures of the same pattern
5. **SNDR** =  $10 \cdot \log_{10}( P_{max}^2 / (\sigma_e^2 + \sigma_n^2) )$  — higher is better
  - The window  $N_p$  bounds how long an impulse response the linear fit can model
  - **Anything longer than  $N_p$  lands in the residual** — it cannot be captured
  - Higher  $N_p$  is used to compensate reflection



# What PoDL/PoC adds to the channel

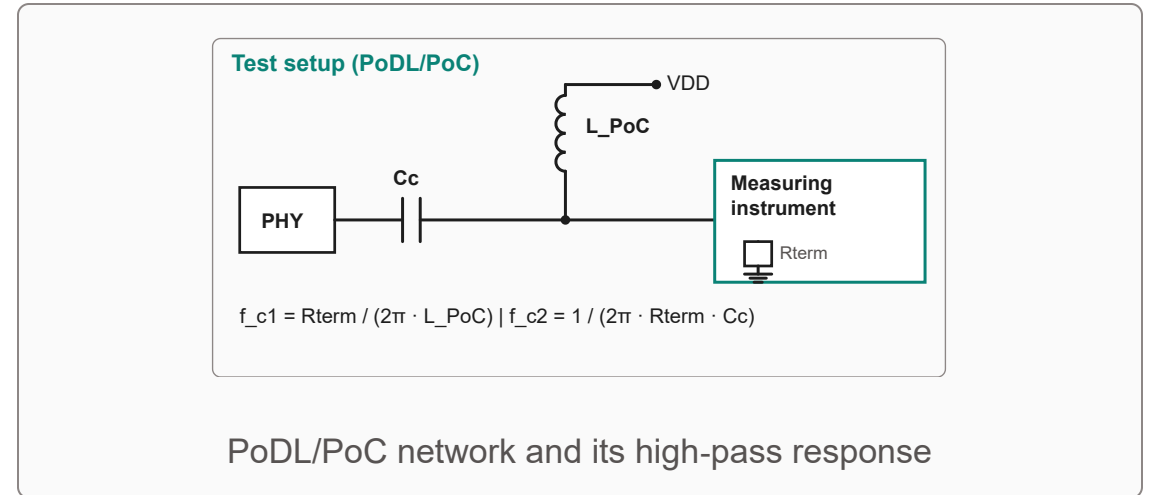
PoDL/PoC feeds DC supply onto the same conductors as the signal. The test signal path is:

- Series **AC coupling cap**  $C_c$  — blocks DC from the PHY
- Shunt **PoC inductor**  $L_{PoC}$  to VDD — passes DC supply, blocks AC

This network is a **low-frequency high-pass** with two real poles:

- $f_{c1} = R_{term} / (2\pi \cdot L_{PoC})$  ← inductor + termination
- $f_{c2} = 1 / (2\pi \cdot R_{term} \cdot C_c)$  ← coupling cap + termination

PRBS13Q still excites significant LF content  $\Rightarrow$  shaped by this HPF  $\Rightarrow$  **baseline wander (BLW)**



- BLW time constants are **orders of magnitude longer than a UI** and typically **exceed  $N_p$**
- The linear fit **cannot capture the slow baseline** — it falls outside the window
- That energy lands in the **residual**  $\Rightarrow$  counted as **nonlinearity** ( $\sigma_e^2$ )
- The repeat-variance step **misclassifies** slowly varying BLW as **random noise** ( $\sigma_n^2$ ), because the baseline is not stationary across pattern repetitions

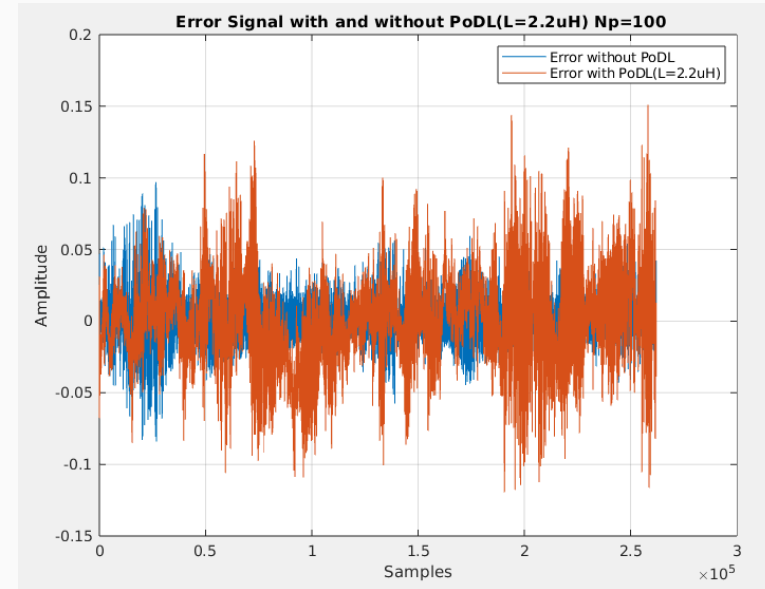
**Net effect:** the SNDR estimator interprets a **linear, deterministic, network-induced** artifact as both distortion and noise — and reports a depressed number for a perfectly compliant device.

Configuration	SNDR
Without PoDL (reference)	40.9 dB
With PoDL (uncompensated)	32.8 dB

- **~8 dB drop** contributed entirely by passive, linear components
- Inductors and capacitors do not generate distortion or noise
- Yet the test attributes the deficit to the PHY

The error-signal trace tells the story:

- **Without PoDL**: residual  $e[n]$  is white-like, no slow trend
- **With PoDL**: residual carries a clear **LF tail** that tracks pattern run-length — signature of a 2nd-order high-pass step response



Error signal (10G, 'Np = 100') — without PoDL (top) vs. with PoDL (bottom)

- **False failures on compliant silicon:** PoDL/PoC baseline wander alone can push a fully compliant transmitter below the SNDR limit, even though the PHY itself meets the spec
- **Result depends on the fixture, not the DUT:** the same PHY can swing several dB simply by inserting or bypassing the PoDL/PoC network — making cross-lab and cross-fixture comparisons unreliable

**Bottom line** — today' TM4 SNDR procedure does not separate **PHY performance** from **fixture response** when PoDL/PoC is present, so it **miscalculates the true SNDR** of the device under test.